



Fraunhofer Entwicklungszentrum
Röntgentechnik

**The EZRT is a joint department of the
Fraunhofer-Institutes IIS Erlangen
and IZFP Saarbrücken/Dresden**

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International Workshop on Imaging NDE
April 25 – 28, 2007, Kalpakkam, India

Fraunhofer EZRT @ INDE 2007

Status of Computed Tomography

Fast Inline CT

Automated Defect Recognition and CT

Dimensional Measurement with CT

In cooperation with:

BAM (Dr. Ewert and Dr. Goebbels, Berlin)

PTB (Dr. Bartscher, Braunschweig)



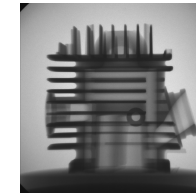
Dimensional Measurement with CT

Industrial 3D-Metrology with
Volume Computed Tomography

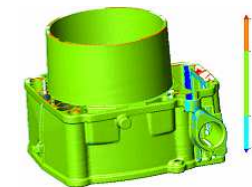
Qualitative → Quantitative



CT for industrial 3D-metrology



nominal / actual
geometry
comparison

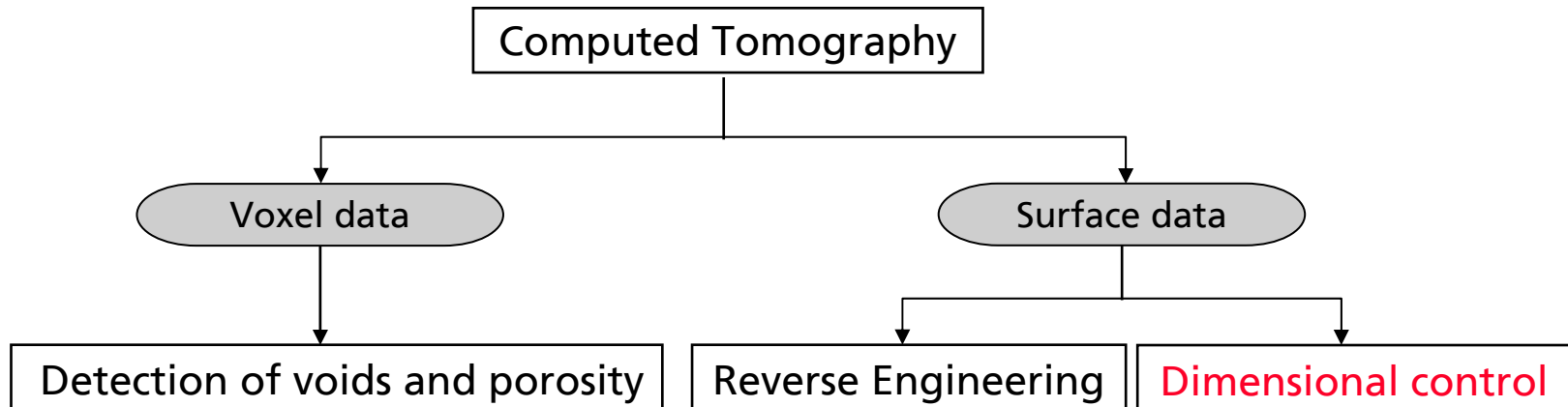


Dimensional Measurement with CT

Overview

- [Introduction and Motivation](#)
- Dimensional Control: Process Chain
- Measurement Uncertainty in CT
- Simulation-based investigation
- Measurement results

Quality inspection in industrial applications with CT



Advantages

- Non-destructive testing method
- Measuring of complex internal structures

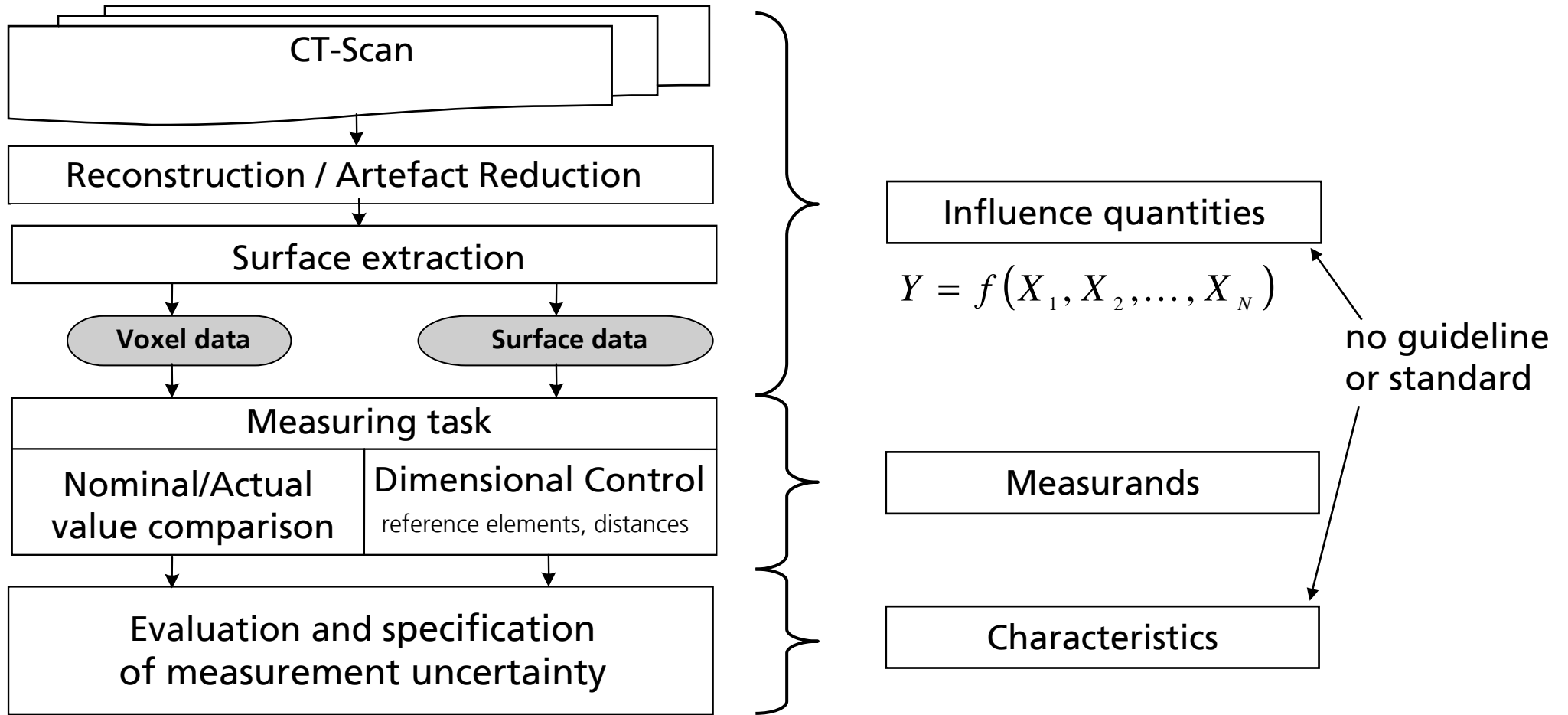
Drawback

- Currently the CT is not yet established as a principle of measurement

Task

- *You must measure the things that are measurable, and make measurable the things that are not. Galileo Galilei (1564 - 1642)*

Dimensional Measurements - Procedure



Dimensional Measurement with CT

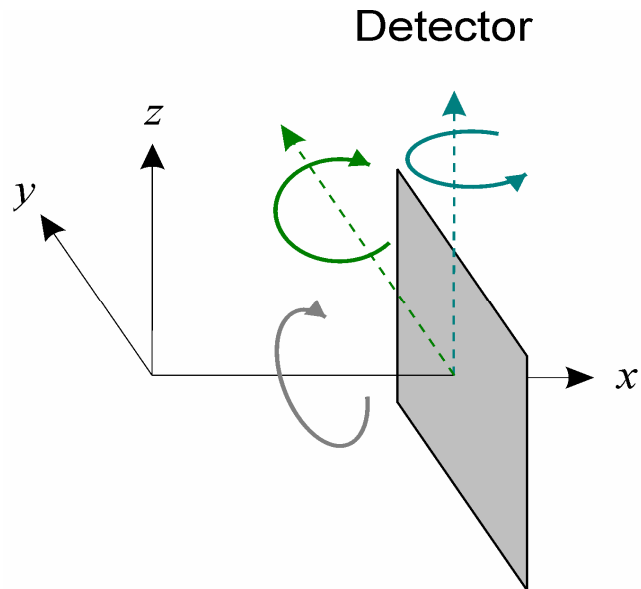
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Dimensional Measurement with CT

Influence quantities in CT

Definition: Quantity that is not the measurand but that affects the result of the measurement



Influence quantities

X-ray tube

- voltage, current
- **prefiltration**

Environment

- temperature
- fouling

Detector

- **exposure time**
- linearity

Axes

- **orthogonality**
- run out radially

Object

- material
- artefacts

Data evaluation

- reconstruction
- surface extraction

Scan parameter

- angular sampling
- integration time

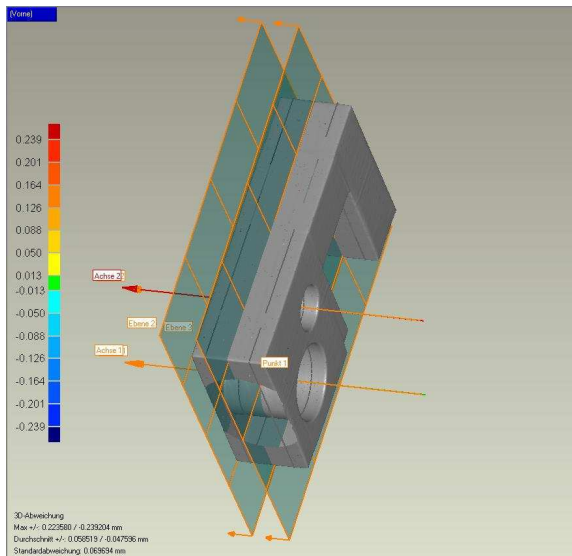
Operator

- operating error
- method

Influence quantities and measurands in CT

Measurands in CT

Definition: Particular quantity subject to measurement



Measurands

Nominal/Actual value comparison

- shrinkage
- shape distortion

Reference element fitting

- probing error
- error of indication for size measurement
- wall thickness analysis

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Characteristics in CT

Definition

Well defined quantifiable number representing an important property of the object thereby allowing to characterizing and optimizing the whole object

Examples: Length, diameter, distance

No measurement result is perfect!

But measurement results

- are important for final inspections of products
- affect the production process

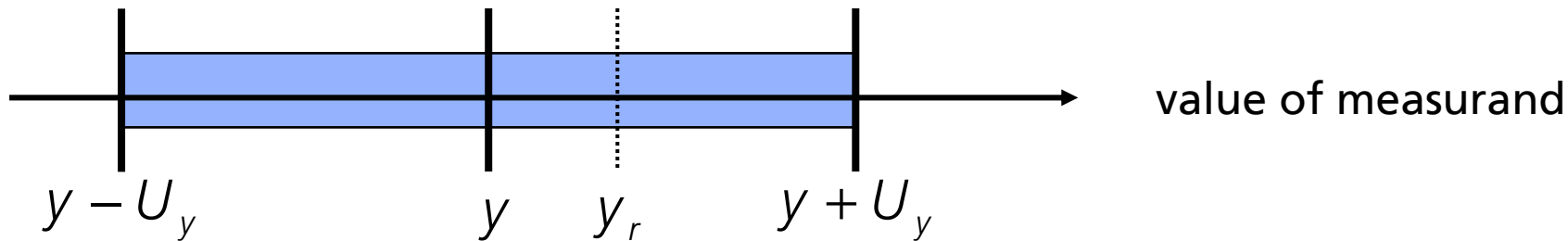
Quality feature of a measurement is the measurement uncertainty!



Definition Measurement Uncertainty

Measurement uncertainty (VIM)

A parameter associated with the result of a measurement that characterizes the dispersion of the values that could reasonably be attributed to the measurand.



Specification of result

measurement result = measured value \pm measurement uncertainty

Symbols: $Y = y \pm U_y$

Evaluation of the measurement uncertainty

according to the **G**uide to the Expression of **U**ncertainty in **M**easurement, 1995

- **worldwide standard** for consistent evaluation of measurement uncertainty,
- **methodically** step-by-step procedure,
- **practical and versatile** modelling concept,
- based on a **solid theoretical** foundation

GUM was developed by cooperation of international organizations:



CT specific problems

- **Many components** influencing the measurement quantity
- **Indirect data** evaluation is done by various algorithms
- Measurement uncertainty depends strongly on the **measurement task and the measurand**
- **Artefacts** reduce image quality



Set up of a model equation for CT measurement procedure is very difficult or nearly impossible.

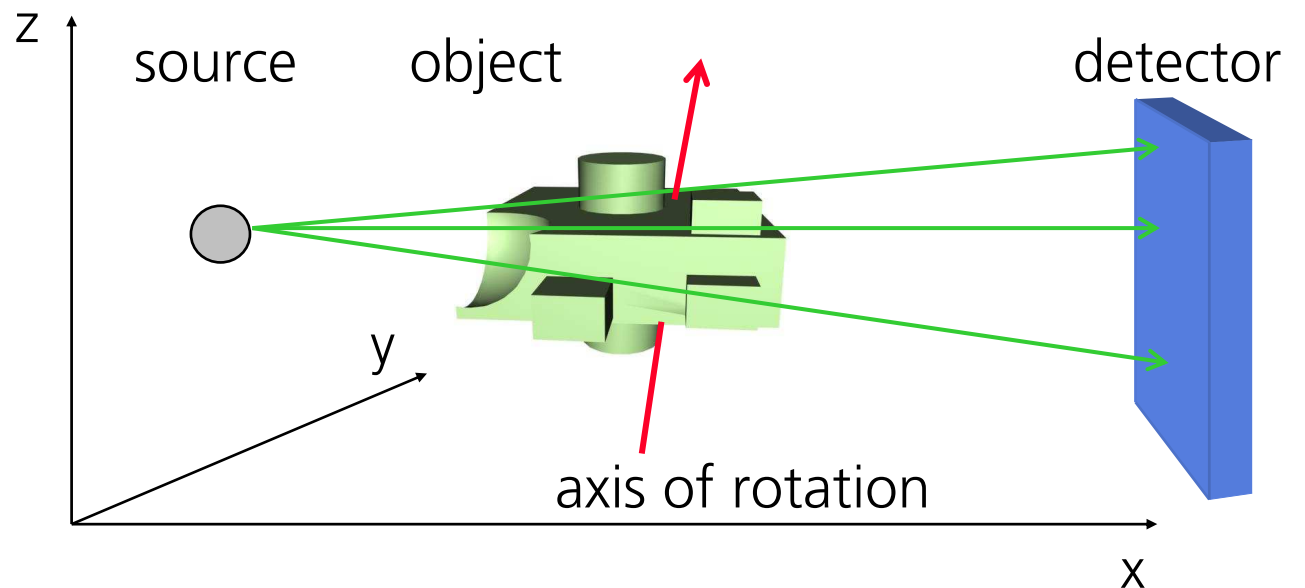
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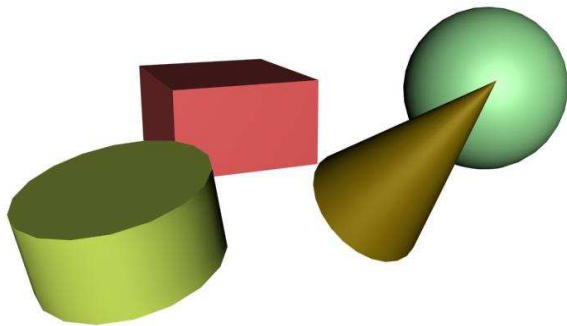
Why simulation?

- Systematic examinations of the influences
- Influences can be **activated separately** e.g. „on-/off“ switching of quantum noise, scattering, beam hardening...
- **No limitations** imposed by availabilities of test objects or CT-systems
- **Exact reproducibility** of conditions and results
- Scheduled for next version of **GUM**



Xlab: CT Simulation Tool

Generation of X-ray projections of virtual objects by simulation



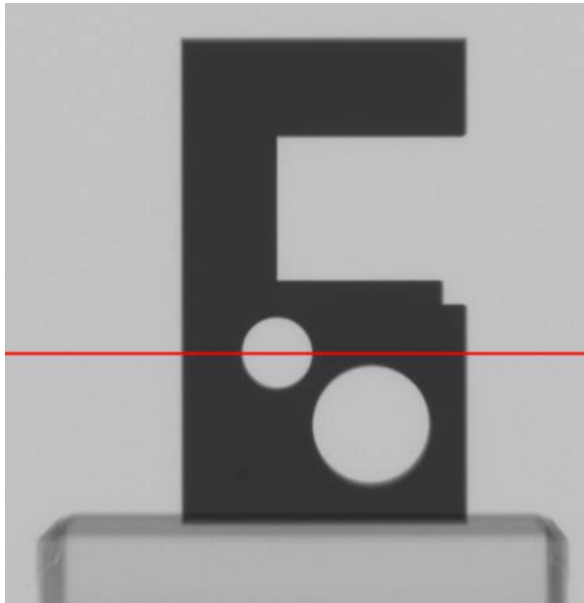
Realization as

- analytical tool,
- ray-based implementation,
- C++ library („XLab“)

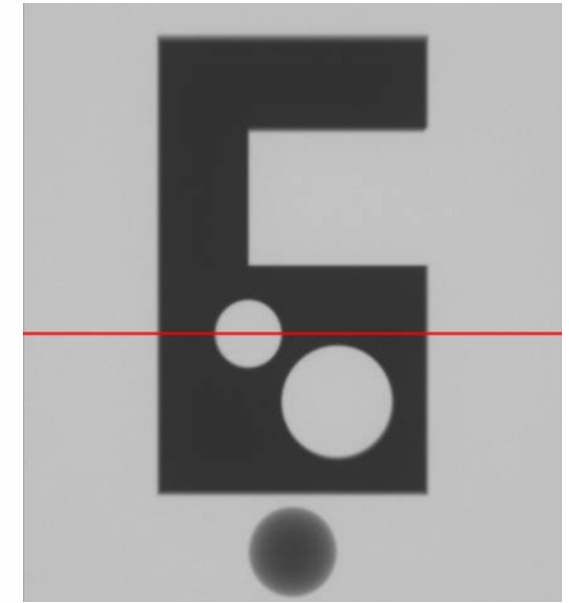
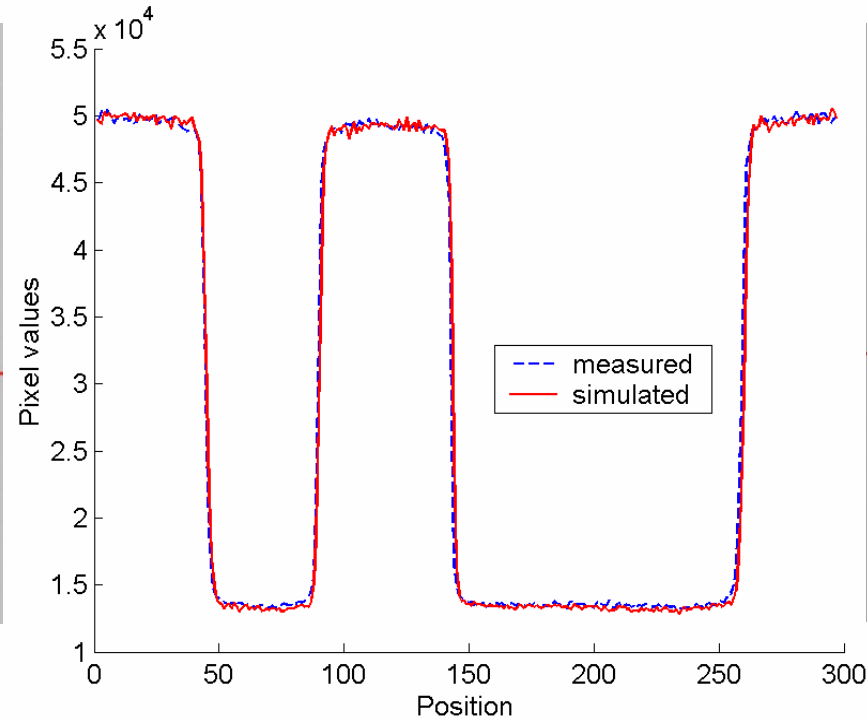
Features

- Multi-material objects
(defined by a composition of primitive geometric objects)
- Quantum noise
- Radiation scattering (LBSA model)
- Pre-filtration (beam hardening)
- Detector blurring

Comparison of Simulated and Measured Projections



measured projection
at tube voltage of 180 kV



simulated projection
polychromatic at 180 kV

source-detector distance: 100 cm
source-object distance: 70 cm
detector resolution: 512 x 512



Dimensional Measurement with CT

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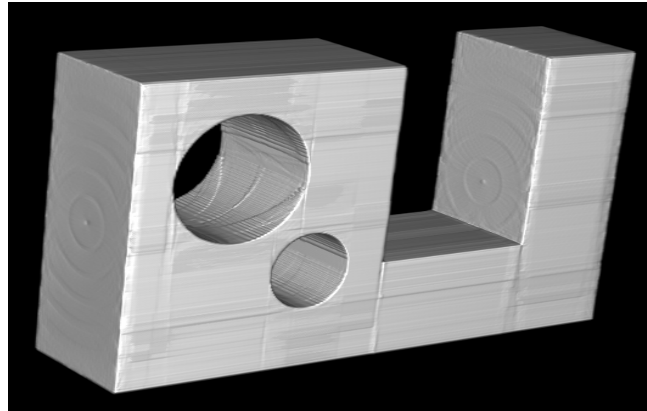
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- **Measurement and results**

Characteristics: 4-sigma value

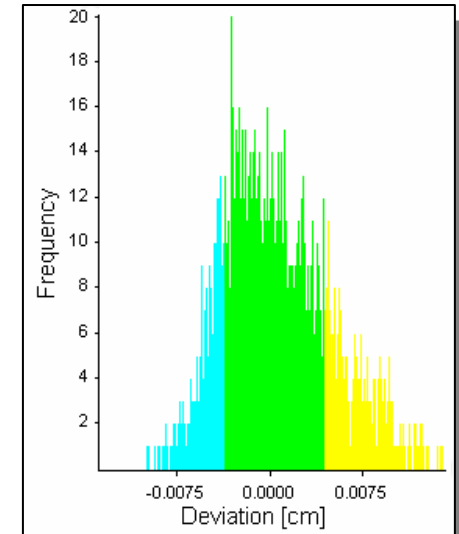
4-sigma value

Error of measurement

- Fit of ten reference elements (8 planes, 2 cylinders)
- calculate fit point deviation histogram (VG Studio)
- calculate mean of the 4-sigma values over all of the ten geometry fits



Test object (aluminum alloy)



Three test scenarios

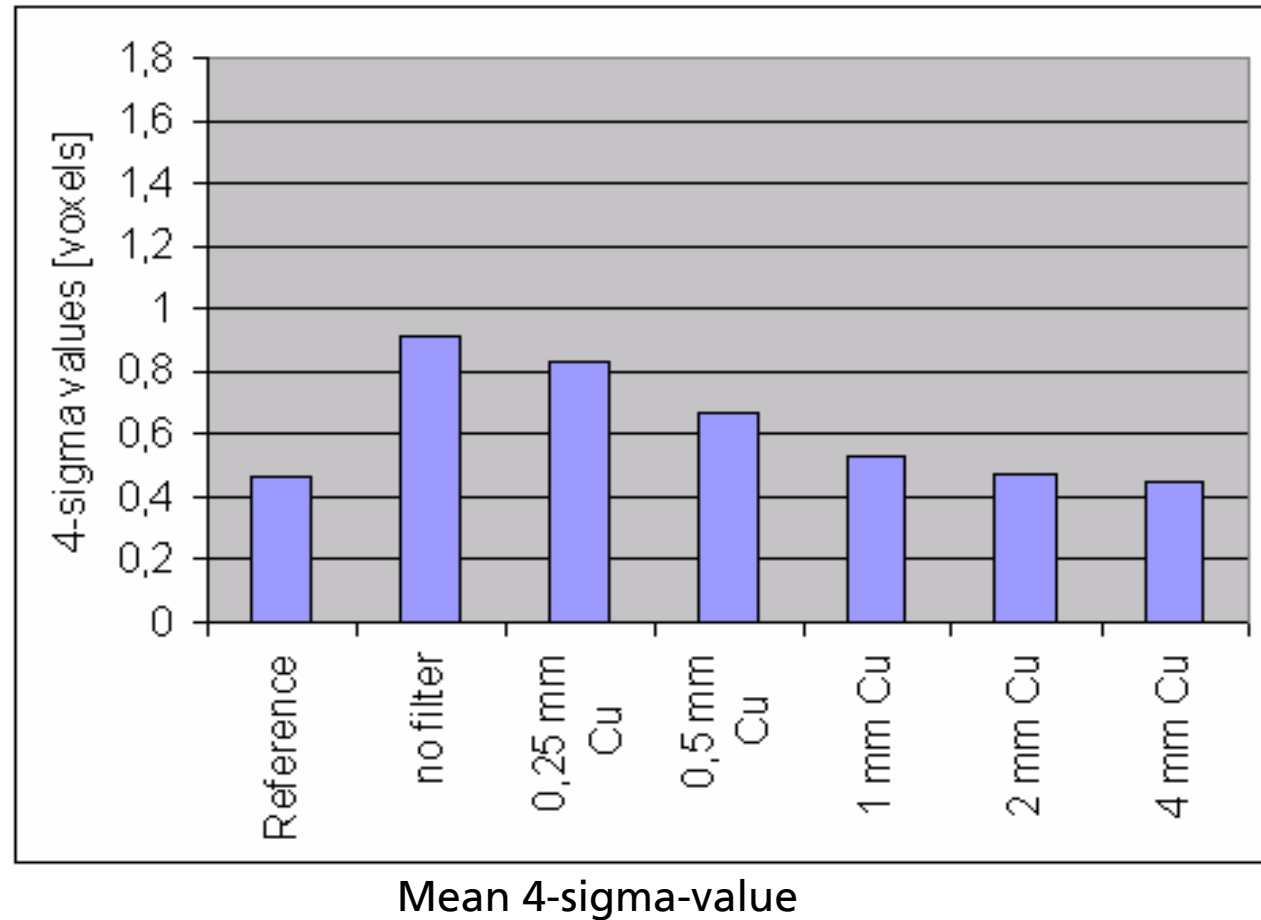
- influence of pre-filtration,
- misalignment of scanning geometry and
- quantum noise

pixel size: 400 x 400 μm
voxel size: 270 x 270 x 270 μm
angular steps: 400



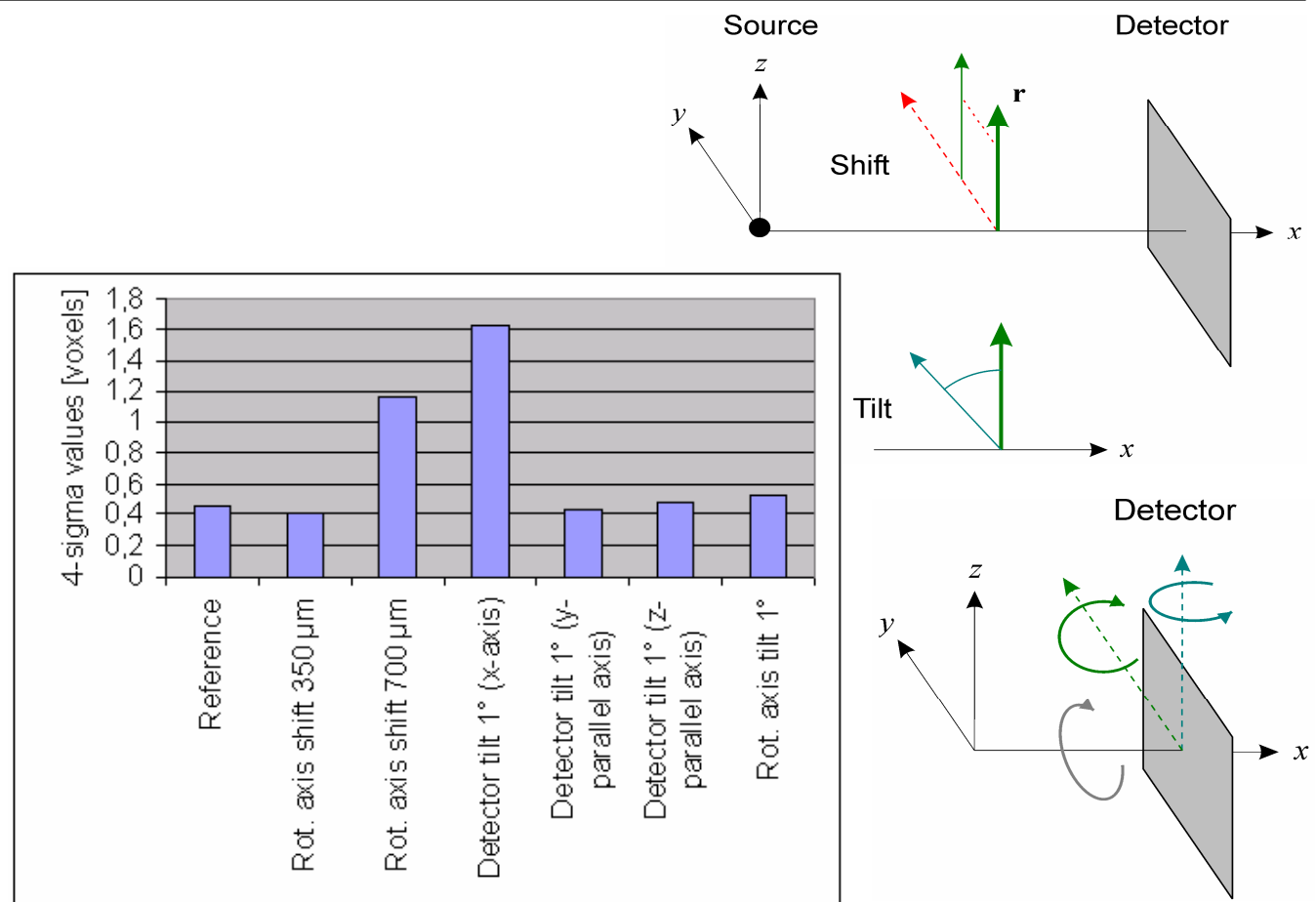
Influence quantity – Pre-filtration

- Copper pre-filtration with thickness: 0 – 4 mm
- 200 kV (reference case: monoenergetic)
- Polychromatic source, without quantum noise and scattering



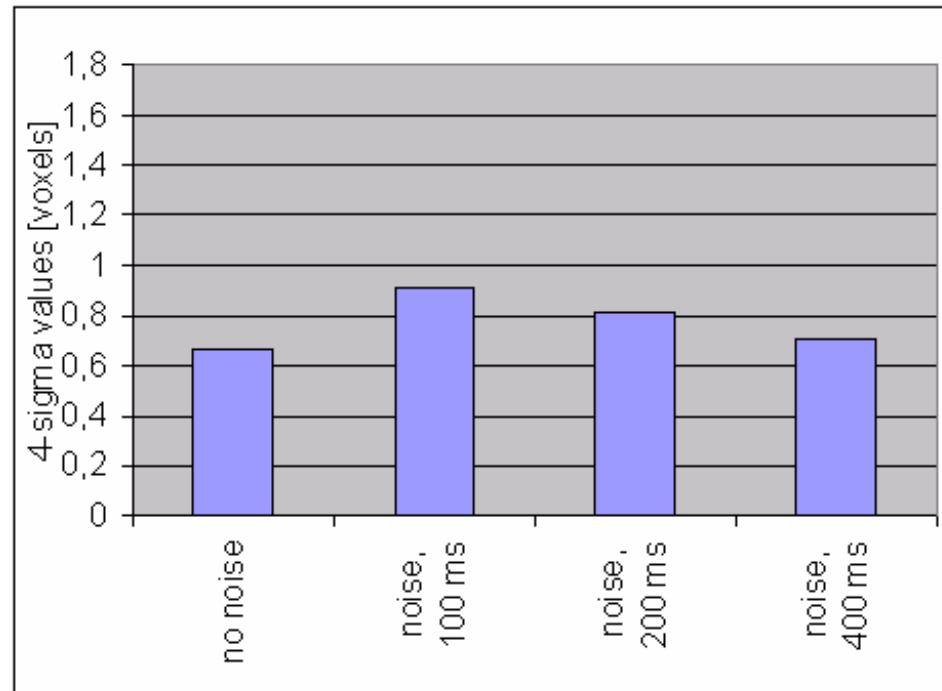
Influence quantity – Misalignment

- Tilt of detector by 1° rotations around its center
- Shift of rotation axis towards y-direction by $350\ \mu\text{m}$ and $700\ \mu\text{m}$
- Tilt of rotation axis out of its z-parallel position
- Reference case: ideal geometric alignment
- Monoenergetic source, without quantum noise and scattering



Influence quantity – Quantum Noise

- Detector exposure time: 100 ms, 200 ms and 400ms
- 200 kV, 100 μ A, 0.5 mm copper pre-filtration
- Reference case: without quantum noise
- Polychromatic source, without scattering



Summary

- CT is a tool for dimensional measurements
- Influence quantities can be identified with simulation tool XLab
- Selection of measurement results
- Most critical parameters are
beam hardening and
the detector tilt around the x-axis

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